

Description

The UPA2815T1S-E2-AT uses advanced trench technology to provide excellent R $_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V.This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = -20V I_{D} = -48A$

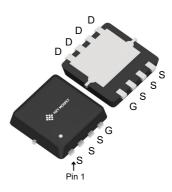
 $R_{DS(ON)}$ < 10 m Ω @ V_{GS} =-4.5 V

Application

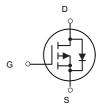
Battery protection

Load switch

Uninterruptible power supply



DFN3X3-8L (HWSON-8(3.3x3.3))



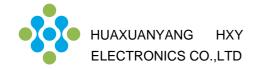
P-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
UPA2815T1S-E2-AT	DFN3X3-8L (HWSON-8(3.3x3.3))	HXY MOSFET	5000

Absolute Maximum Ratings (T_A=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-20	V
Vgs	Gate-Source Voltage	±8	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ -4.5V ¹	-48	А
I _D @T _C =70°C	Continuous Drain Current, V _{GS} @ -4.5V ¹	-35	А
Ірм	Pulsed Drain Current ²	-100	А
P _D @T _C =25°C	Total Power Dissipation ³	29	W
P _D @T _C =70°C	Total Power Dissipation ³	19	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
ReJA	Thermal Resistance Junction-Ambient ¹	75	°C/W
ReJA	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	40	°C/W
Rejc	Thermal Resistance Junction-Case ¹	4.2	°C/W



Electrical Characteristics (T_A=25 °C unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-20	-24		V
ΔBV DSS /	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.012		V/°C
		V _{GS} =-4.5V , I _D =-10A		7.5	10	
RDS(ON)	Static Drain-Source On-Resistance ²	V_{GS} =-2.5V , I_D =-8A		8.7	11.5	mΩ
		V _{GS} =-1.8V , I _D =-6A		13	15	
$V_{\text{GS(th)}}$	Gate Threshold Voltage		-0.3	0.6	-1.0	V
ΔV GS(th)	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250$ uA		2.94		mV/°C
loss	Drain-Source Leakage Current	V _{DS} =-20V , V _{GS} =0V , T _J =25°C			1	uA
Igss	Gate-Source Leakage Current	V _{GS} =±8V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-10A		43		S
Qg	Total Gate Charge (-4.5V)			63		
Qgs	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V ,		9.1		nC
Qgd	Gate-Drain Charge	I _D =-10A		13		
T _{d(on)}	Turn-On Delay Time			15.8		
Tr	Rise Time	V _{DD} =-10V , V _{GS} =-4.5V ,		76.8		
T _d (off)	Turn-Off Delay Time	R _G =3.3 , I _D =-10A		193		ns
Tf	Fall Time			186.4		•
Ciss	Input Capacitance			5783		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		509		pF
Crss	Reverse Transfer Capacitance			431		
ls	Continuous Source Current ^{1,4}	V _G =V _D =0V , Force Current			-10.7	Α
lsм	Pulsed Source Current ^{2,4}				-60	Α
Vsp	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1.2	V
trr	Reverse Recovery Time	IF=-10A , dI/dt=100A/μs ,		27		nS
Qrr	Reverse Recovery Charge	 TJ =25°C		17.8		nC

Note

^{1.}The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width $\leqq 300 us$, duty cycle $\leqq 2\%$

^{3.}The power dissipation is limited by 150°C junction temperature

^{4.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

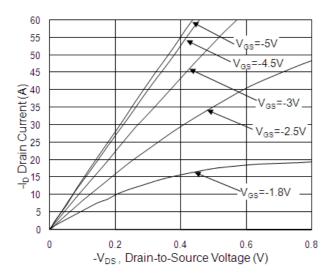


Fig.1 Typical Output Characteristics

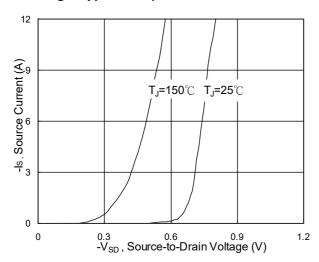


Fig.3 Forward Characteristics of Reverse

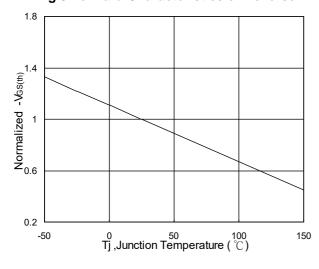


Fig.5 Normalized V_{GS(th)} vs. T_J

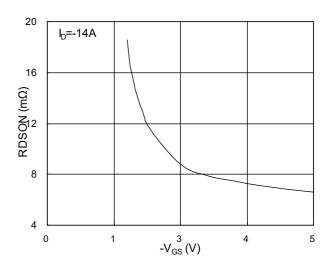


Fig.2 On-Resistance vs. G-S Voltage

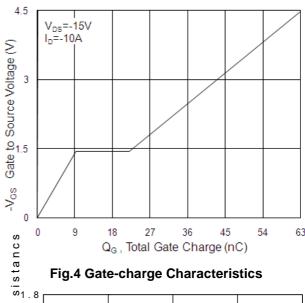


Fig.4 Gate-charge Characteristics

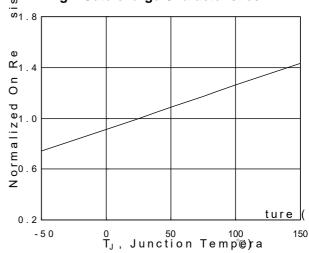
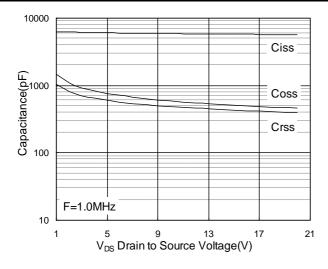


Fig.6 Normalized R_{DSON} vs. T_J





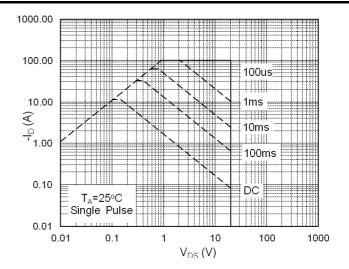


Fig.7 Capacitance

Fig.8 Safe Operating Area

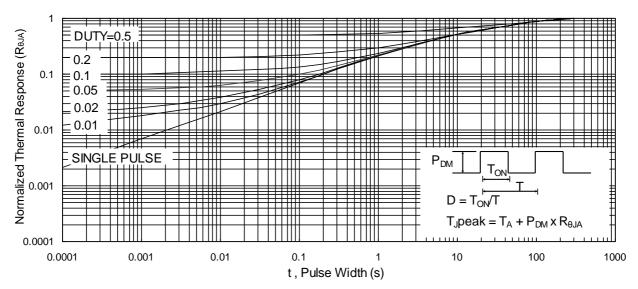
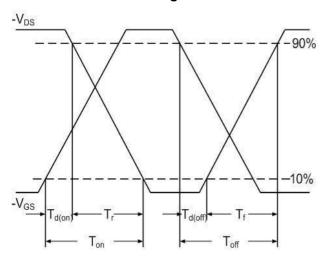


Fig.9 Normalized Maximum Transient Thermal Impedance





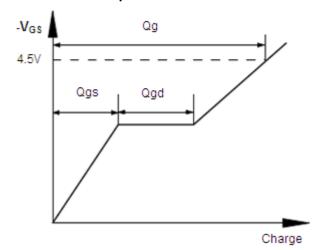
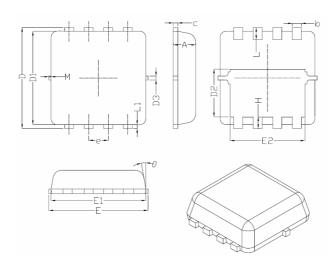


Fig.11 Gate Charge Waveform



DFN3X3-8L(HWSON-8(3.3x3.3)) Package Information



Complicat	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
M	*	*	0.15	
θ		10 [°]	12 [°]	

P-Channel Enhancement Mode MOSFET

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